THE DATASHEET OF

TDA8034T/C1,112

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TDA8034T; TDA8034AT

Smart card interface

Rev. 3.1 — 13 December 2012 Product data sheet

1. General description

The TDA8034T/TDA8034AT is a cost-effective analog interface for asynchronous and synchronous smart cards operating at 5 V or 3 V. Using few external components, the TDA8034T/TDA8034AT provides all supply, protection and control functions between a smart card and the microcontroller.

2. Features and benefits

- Integrated circuit smart card interface in an SO16 package
- 5 V or 3 V smart card supply
- One protected half-duplex bidirectional buffered I/O line (C7)
- V_{CC} regulation:
  - 5 V ± 5 % or 3 V ± 5 % using two low ESR multilayer ceramic capacitors: one of 220 nF and one of 470 nF
  - current spikes of 40 nA/s (V_{CC} = 5 V and 3 V) or 15 nA/s (V_{CC} =1.8 V) up to 20 MHz, with controlled rise and fall times and filtered overload detection of approximately 120 mA
- Thermal and short-circuit protection for all card contacts
- Automatic activation and deactivation sequences triggered by a short-circuit, card take-off, overheating, falling V_{DD}, $V_{DD(INTF)}$ or V_{DDP}
- Enhanced card-side ElectroStatic Discharge (ESD) protection of > 6 kV
- External clock input up to 26 MHz connected to pin XTAL1
- Card clock generation up to 20 MHz using pin CLKDIV1 with synchronous frequency changes of:
  - ½ f_{xtal} or ¼ f_{xtal} on TDA8034T
  - f_{xtal} or ½ f_{xtal} on TDA8034AT
- Non-inverted control of pin RST using pin RSTIN
- Compatible with ISO 7816, NDS and EMV 4.2 payment systems
- Supply supervisor for killing spikes during power on and off:
  - using a fixed threshold
  - using an external resistor bridge with threshold adjustment
- Built-in debouncing on card presence contacts (typically 4.5 ms)
- Multiplexed status signal using pin OFFN

3. Applications

- Pay TV
- Electronic payment

- Identification
- Bank card readers

4. Quick reference data

Table 1. Quick reference data

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Supply						
V_{DDP}	power supply voltage	pin V_{DDP}	4.85	5	5.5	V
V_{DD}	supply voltage	pin V_{DD}	2.7	3.3	3.6	V
$V_{DD(INTF)}$	interface supply voltage	pin $V_{DD(INTF)}$	1.6	3.3	V_{DD} + 0.3	V
I_{DD}	supply current	Shutdown mode	-	-	35	µA
I_{DDP}	power supply current	Shutdown mode; f_{xtal} stopped	-	-	5	µA
		Active mode; f_{CLK} = ½ f_{xtal}; no load	-	-	1.5	mA
$I_{DD(INTF)}$	interface supply current	Shutdown mode	-	-	6	µA
Card supply voltage: pin V_{CC}[1]						
V_{CC}	supply voltage	active mode				
		5 V card				
		I_{CC} < 65 mA DC	4.75	5.0	5.25	V
		current pulses of 40 nA/s at I_{CC} < 200 mA; t < 400 ns	4.65	5.0	5.25	V
$V_{ripple(p-p)}$	peak-to-peak ripple voltage	from 20 kHz to 200 MHz	-	-	350	mV
I_{CC}	supply current	V_{CC} = 0 V to 5 V or 3 V	-	-	65	mA
General						
t_{deact}	deactivation time	see Figure 7 on page 11	35	90	250	µs
P_{tot}	total power dissipation	T_{amb} = −25 °C to +85 °C	-	-	0.25	W
T_{amb}	ambient temperature		−25	-	+85	°C

[1] To meet these specifications, V_{CC} should be decoupled to pin GND using two ceramic multilayer capacitors of low ESR with values of either 100 nF or one 220 nF and one 470 nF.

5. Ordering information

Table 2. Ordering information

Type number	Package		
	Name	Description	Version
TDA8034T/C1	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
TDA8034AT/C1			

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6. Block diagram

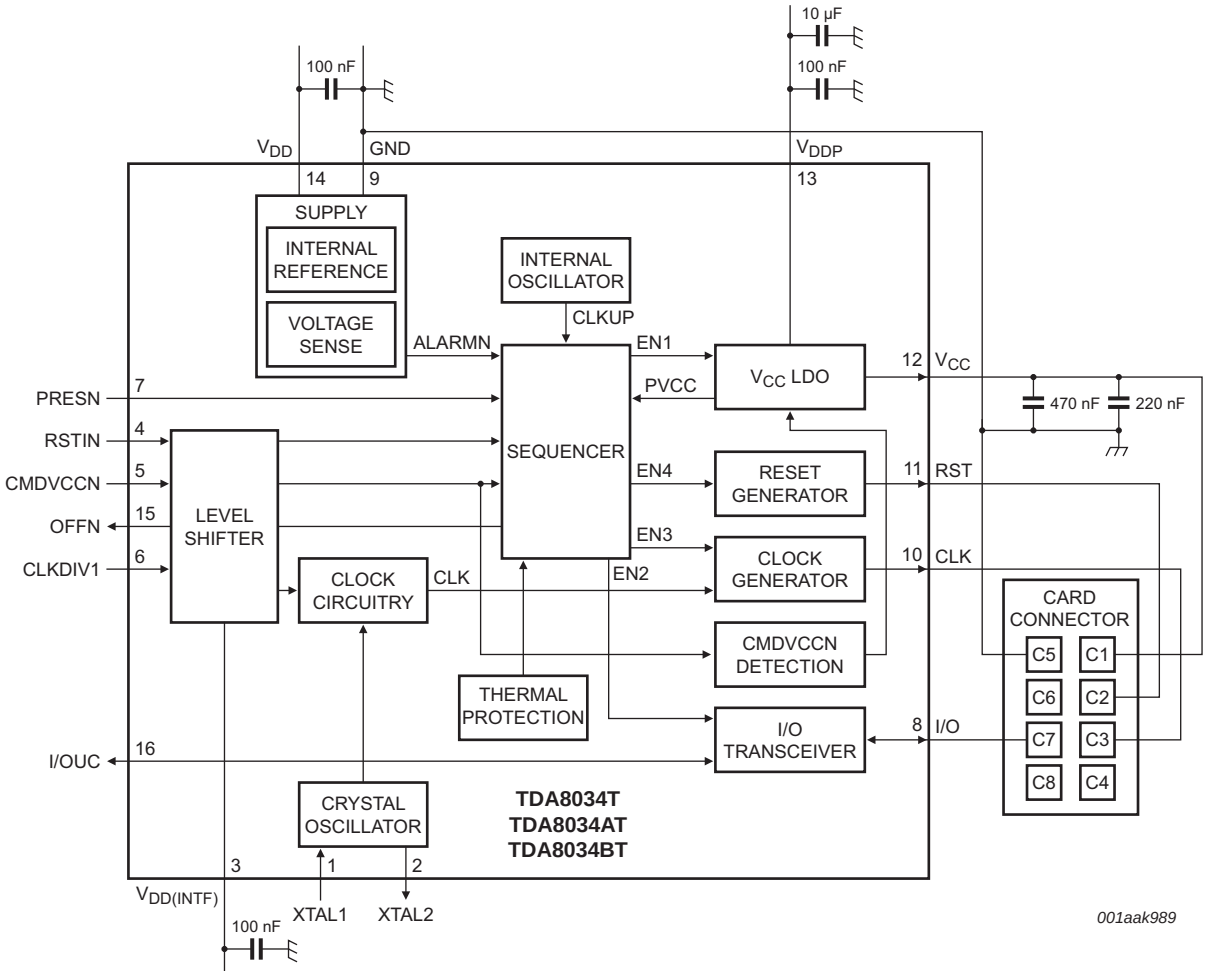

Fig 1. Block diagram

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7. Pinning information

7.1 Pinning

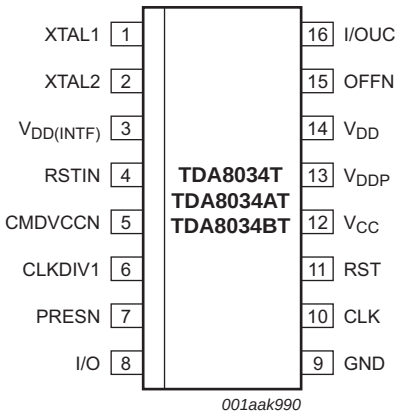

Fig 2. Pin configuration (SO16)

7.2 Pin description

Table 3. Pin description

Symbol	Pin	Supply	Type[1]	Description
XTAL1	1	V_{DD}	I	crystal connection input
XTAL2	2	V_{DD}	O	crystal connection output
$V_{DD(INTF)}$	3	$V_{DD(INTF)}$	P	interface supply voltage
RSTIN	4	$V_{DD(INTF)}$	I	microcontroller card reset input; active HIGH
CMDVCCN	5	$V_{DD(INTF)}$	I	microcontroller start activation sequence input; active LOW
CLKDIV1	6	$V_{DD(INTF)}$	I	sets the clock frequency on pin CLK; see Table 4 on page 7
PRESN	7	$V_{DD(INTF)}$	I	card presence contact input; active LOW[2]
I/O	8	V_{CC}	I/O	card input/output data line (C7)[3]
GND	9	-	G	ground
CLK	10	V_{CC}	O	card clock (C3)
RST	11	V_{CC}	O	card reset (C2)
V_{CC}	12	V_{CC}	P	card supply (C1); decouple to pin GND using one 470 nF capacitor close to pin V_{CC} and one 220 nF capacitor close to card socket contact C1 with an ESR < 100 mΩ[4]
V_{DDP}	13	V_{DDP}	P	low-dropout regulator input supply voltage
V_{DD}	14	V_{DD}	P	digital supply voltage
OFFN	15	$V_{DD(INTF)}$	O	NMOS interrupt to microcontroller[5]; active LOW; see Section 8.9 on page 11
I/OUC	16	$V_{DD(INTF)}$	I/O	microcontroller input/output data line[6]

[1] I = input, O = output, I/O = input/output, G = ground and P = power supply.

[2] If pin PRESN is LOW, the card is considered to be present. During card insertion, debouncing can occur on these signals. To counter this, the TDA8034T/TDA8034AT has a built-in debouncing timer (typically 4.5 ms).

[3] Uses an internal 11 kΩ pull-up resistor connected to pin V_{CC}.

[4] Using a 220 nF capacitor increases the noise margin on pin V_{CC}.

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[5] Uses an internal 20 kΩ pull-up resistor connected to pin $V_{DD(INTF)}$.

[6] Uses an internal 10 kΩ pull-up resistor connected to pin $V_{DD(INTF)}$.

8. Functional description

Remark: Throughout this document the ISO 7816 terminology conventions have been adhered to and it is assumed that the reader is familiar with these.

8.1 Power supplies

The power supply voltage ranges are as follows:

- V_{DDP}: 4.85 V to 5.5 V
- V_{DD}: 2.7 V to 3.6 V

V_{DD} should rise prior to V_{DDP} or at the same time. V_{DDP} should not rise before V_{DD}.

All interface signals to the system controller are referenced to $V_{DD(INTF)}$. All card contacts remain inactive during power up or power down. After powering up the device, pin OFFN remains LOW until pin CMDVCCN is set HIGH and pin PRESN is LOW. During power down, pin OFFN goes LOW when V_{DDP} falls below the falling threshold voltage (V_{th}).

The internal oscillator frequency ($f_{osc(int)}$) is only used during the activation sequences. When the card is not activated (pin CMDVCCN is HIGH), the internal oscillator is in low frequency mode to reduce power consumption.

This device has a Low Drop-Off (LDO) voltage regulator connected to pin V_{CC}, and is used instead of a DC-to-DC converter. It ensures a minimum V_{CC} of 4.75 V and that the power supply voltage on pin V_{DDP} does not fall below 4.85 V for a maximum load current of 65 mA.

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8.2 Voltage supervisor

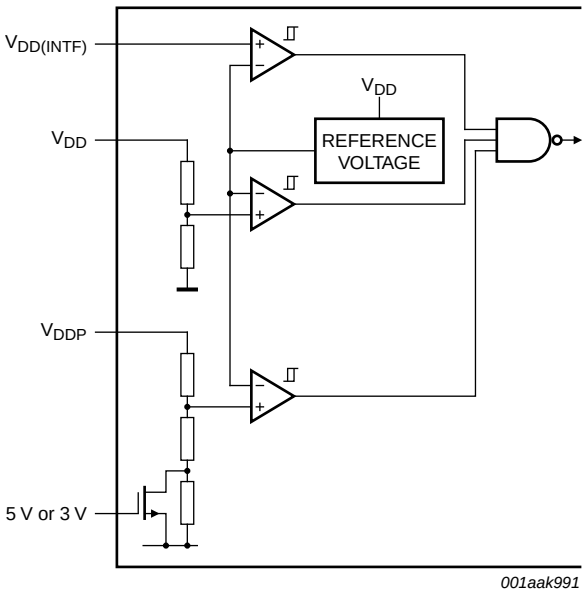

Fig 3. Voltage supervisor circuit

The voltage supervisor monitors the voltage of the V_{DDP} and V_{DD} supplies providing both Power-On Reset (POR) and supply drop-out detection during a card session. The supervisor threshold voltages for V_{DDP} and V_{DD} are set internally. As long as V_{DD} is less than $V_{th} + V_{hys}$, the IC remains inactive irrespective of the command line levels. After V_{DD} has reached a level higher than $V_{th} + V_{hys}$, the IC remains inactive for the duration of t_w. The output of the supervisor is sent to a digital controller in order to reset the TDA8034T/TDA8034AT. This defined reset pulse of approximately 8 ms, i.e. ($t_w = 1024 \times {}^{1}/_{f_{osc(int)low}}$), is used internally to maintain the IC in the Shutdown mode during the supply voltage power on; see Figure 4. A deactivation sequence is performed when either V_{DD} or V_{DDP} falls below V_{th}.

Remark: $f_{osc(int)low}$ is the low frequency (or inactive) mode of the defined $f_{osc(int)}$ parameter.

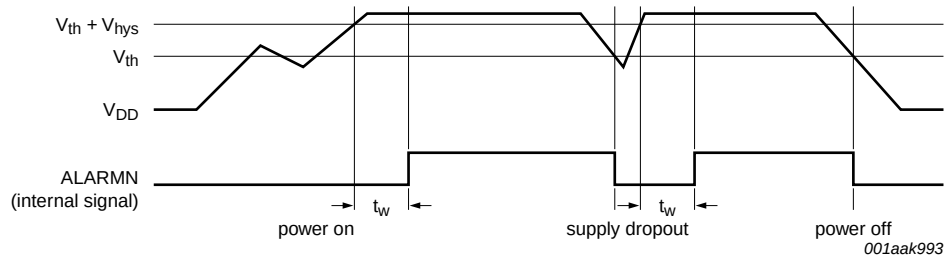

Fig 4. Voltage supervisor waveforms

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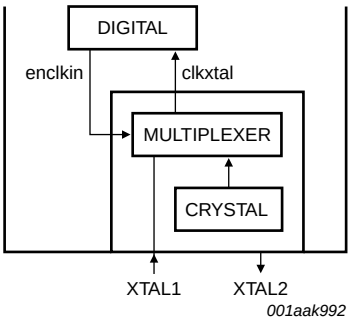
8.3 Clock circuits

The clock signal from pin CLK to the card is either supplied by an external clock signal connected to pin XTAL1 or generated using a crystal connected between pins XTAL1 and XTAL2. The TDA8034T/TDA8034AT automatically detects if an external clock is connected to XTAL1, eliminating the need for a separate pin to select the clock source.

Automatic clock source detection is performed on each activation command (falling edge of the signal on pin CMDVCCN). The presence of an external clock on pin XTAL1 is checked during a time window defined by the internal oscillator. If a clock is detected, the internal crystal oscillator is stopped. If a clock is not detected, the internal crystal oscillator is started. When an external clock is used, it is mandatory that the clock is applied to pin XTAL1 before the falling edge of the signal on pin CMDVCCN.



enclkin and clkxtal are internal signal names.

Fig 5. Basic layout for using an external clock

The clock frequency is selected using pin CLKDIV1 to be either $\frac{1}{2}$ f_{xtal} or $\frac{1}{4}$ f_{xtal} on TDA8034T or f_{xtal} or $\frac{1}{2}$ f_{xtal} on TDA8034AT as shown in Table 4.

The frequency change is synchronous and as such during transition, no pulse is shorter than 45 % of the smallest period. In addition, only the first and last clock pulse around the change has the correct width. When dynamically changing the frequency, the modification is only effective after 10 clock periods on pin XTAL1.

The duty cycle of f_{xtal} on pin CLK should be between 45 % and 55 %. If an external clock is connected to pin XTAL1, its duty cycle must be between 48 % and 52 %.

When the frequency of the clock signal on pin CLK is either $\frac{1}{2}$ f_{xtal} or $\frac{1}{4}$ f_{xtal} on TDA8034T or f_{xtal} or $\frac{1}{2}$ f_{xtal} on TDA8034AT, the frequency dividers guarantee a duty cycle between 45 % and 55 %.

Table 4. Clock configuration

Pin CLKDIV1 level	Pin CLK level	
	TDA8034T	TDA8034AT
HIGH	$\frac{1}{2}$ f_{xtal}	$\frac{1}{2}$ f_{xtal}
LOW	$\frac{1}{4}$ f_{xtal}	f_{xtal}

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8.4 Input and output circuits

When pins I/O and I/OUC are pulled HIGH using an 11 kΩ resistor between pins I/O and V_{CC} and/or between pins I/OUC and $V_{DD(INTF)}$, both lines enter the idle state. Pin I/O is referenced to V_{CC} and pin I/OUC to $V_{DD(INTF)}$, thus allowing operation at $V_{CC} \neq V_{DD(INTF)}$.

The first side on which a falling edge occurs becomes the master. An anti-latch circuit disables falling edge detection on the other line, making it the slave. After a time delay t_d, the logic 0 present on the master-side is sent to the slave-side. When the master-side returns logic 1, the slave-side sends logic 1 during time delay ($t_{w(pu)}$). After this sequence, both master and slave sides return to their idle states.

The active pull-up feature ensures fast LOW-to-HIGH transitions making the TDA8034T/TDA8034AT capable of delivering more than 1 mA, up to an output voltage of $0.9V_{CC}$, at a load of 80 pF. At the end of the active pull-up pulse, the output voltage is dependent on the internal pull-up resistor value and load current. The current sent to and received from the card's I/O lines is limited to 15 mA at a maximum frequency of 1 MHz.

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8.5 Shutdown mode

After a power-on reset, if pin CMDVCCN is HIGH, the circuit enters the Shutdown mode, ensuring only the minimum number of circuits are active while the TDA8034T/TDA8034AT waits for the microcontroller to start a session.

- all card contacts are inactive. The impedance between the contacts and GND is approximately 200 Ω.
- pin I/OUC is high-impedance using the 11 kΩ pull-up resistor connected to $V_{DD(INTF)}$
- the voltage generators are stopped
- the voltage supervisor is active
- the internal oscillator runs at its lowest frequency ($f_{osc(int)low}$)

8.6 Activation sequence

The following device activation sequence is applied when using an external clock; see Figure 6:

1. Pin CMDVCCN is pulled LOW (t0).
2. The internal oscillator is triggered (t0).
3. The internal oscillator changes to high frequency (t1).
4. V_{CC} rises from either 0 V to 3 V or 0 V to 5 V on a controlled slope (t2).
5. Pin I/O is driven HIGH (t3).
6. The clock on pin CLK is applied to the C3 contact (t4).
7. Pin RST is enabled (t5).

Calculation of the time delays is as follows:

- t1 = t0 + 384 × $^{1}/_{f_{osc(int)low}}$
- t2 = t1
- t3 = t1 + 17T / 2
- t4 = driven by host controller; > t3 and < t5
- t5 = t1 + 23T / 2

Remark: The value of period T is 64 times the period interval of the internal oscillator at high frequency ($^{1}/_{f_{osc(int)high}}$); t3 is called $t_{d(start)}$ and t5 is called $t_{d(end)}$.

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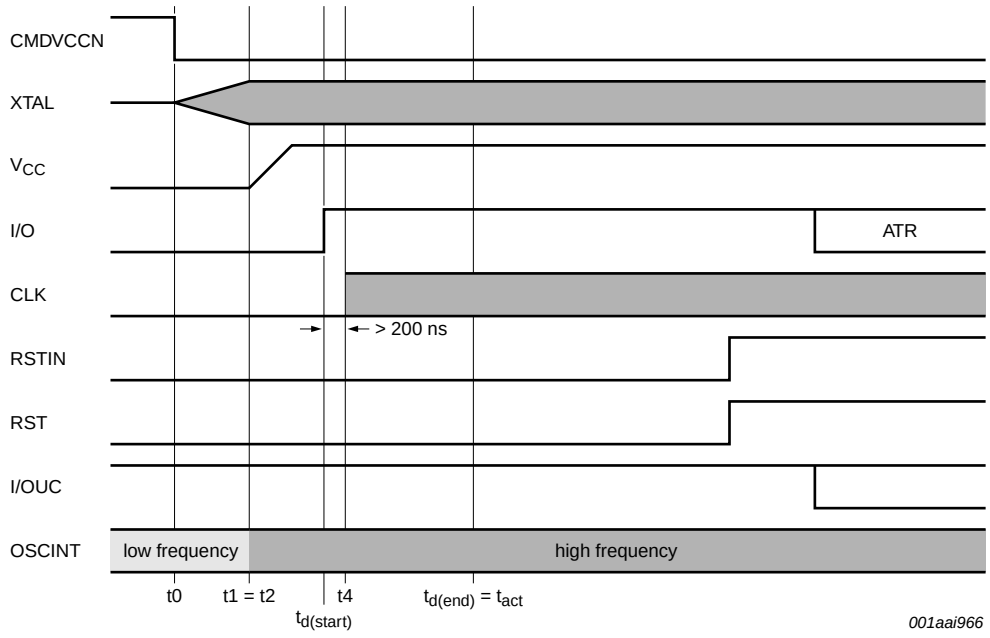

OSCINT = internal oscillator.

Fig 6. Activation sequence at t3

8.7 Deactivation sequence

When a session ends, the microcontroller sets pin CMDVCCN HIGH. The TDA8034T/TDA8034AT then executes an automatic deactivation sequence by counting the sequencer back to the inactive state (see Figure 7) as follows:

1. Pin RST is pulled LOW (t11).
2. The clock is stopped, pin CLK is LOW (t12).
3. Pin I/O is pulled LOW (t13).
4. V_{CC} falls to 0 V (t14). The deactivation sequence is completed when V_{CC} reaches its inactive state.
5. V_{CC} < 0.4 V (t_{deac})
6. All card contacts become low-impedance to GND. However, pin I/OUC remains pulled up to V_{DD} using the 11 kΩ resistor.
7. The internal oscillator returns to its low frequency mode.

Calculation of the time delays is as follows:

- t11 = t10 + 3T / 64
- t12 = t11 + T / 2
- t13 = t11 + T
- t14 = t11 + 3T / 2
- t_{deac} = t11 + 3T / 2 + V_{CC} fall time

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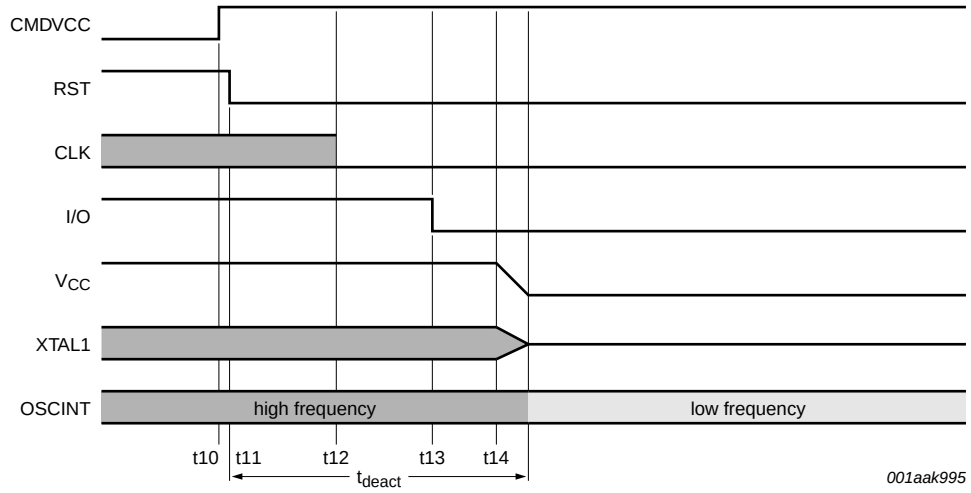
Remark: The value of period T is 64 times the period interval of the internal oscillator (i.e. ± 25 μs).



OSCINT = internal oscillator.

Fig 7. Deactivation sequence

8.8 V_{CC} regulator

The V_{CC} buffer is able to continuously deliver up to 65 mA at V_{CC} = 5 V or 3 V.

The V_{CC} buffer has an internal overload protection with a threshold value of approximately 120 mA. This detection is internally filtered, enabling spurious current pulses up to 200 mA with a duration of a few milliseconds to be drawn by the card without causing deactivation. However, the average current value must stay below maximum; see Table 8.

8.9 Fault detection

The following conditions are monitored by the fault detection circuit:

- Short-circuit or high current on pin V_{CC}
- Card removal during transaction
- V_{DDP} falling
- V_{DD} falling
- $V_{DD(INTF)}$ falling
- Overheating

Fault detection monitors two different situations:

- Outside card sessions, pin CMDVCCN is HIGH: pin OFFN is LOW if the card is not in the reader and HIGH if the card is in the reader. Any voltage drop on V_{DD} is detected by the voltage supervisor. This generates an internal power-on reset pulse but does not act upon the pin OFFN signal. The card is not powered-up and short-circuits or overheating are not detected.

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- In card sessions, pin CMDVCCN is LOW: when pin OFFN goes LOW, the fault detection circuit triggers the automatic emergency deactivation sequence (see Figure 8). When the microcontroller resets pin CMDVCCN to HIGH, after the deactivation sequence, pin OFFN is rechecked. If the card is still present, pin OFFN returns to HIGH. This check identifies the fault as either a hardware problem or a card removal incident.

On card insertion or removal, bouncing can occur in the PRESN signal. This depends on the type of card presence switch in the connector (normally open or normally closed) and the mechanical characteristics of the switch. To correct for this, a debouncing feature is integrated in to the TDA8034T/TDA8034AT. This feature operates at a typical duration of 4.5 ms (t_{deb} = 640 × ($^{1}/_{f_{osc(int)low}}$). Figure 9 on page 13 shows the operation of the debouncing feature.

On card insertion, pin OFFN goes HIGH after the debounce time has elapsed. When the card is extracted, the automatic card deactivation sequence is performed on the first HIGH/LOW transition on pin PRESN. After this, pin OFFN goes LOW.

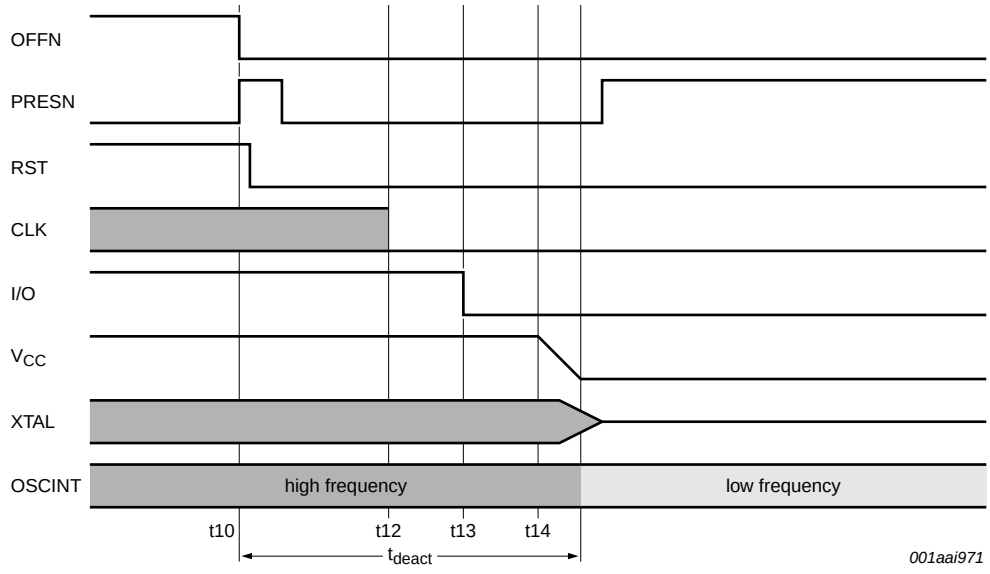

Fig 8. Emergency deactivation sequence after card removal

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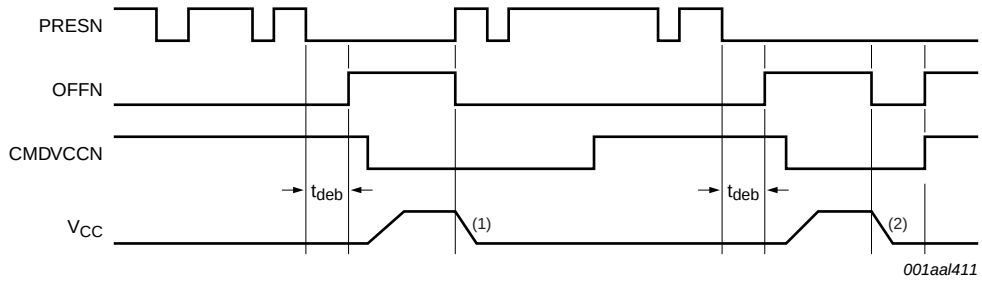

(1) Deactivation caused by card withdrawal.

(2) Deactivation caused by short-circuit.

Fig 9. Operation of debounce feature with pins OFFN, CMDVCCN, PRESN and V_{CC}

8.10 Automatic determining of card supply voltage

The supply voltage (V_{CC}) that the card requires is determined automatically by monitoring the duration of the HIGH state (logic 1) on pin CMDVCCN before the activation command (CMDVCCN falling edge) occurs. If pin CMDVCCN stays HIGH for more than 30 ms, activation occurs with V_{CC} set to 5 V. If pin CMDVCCN stays HIGH for less than 15 ms, activation occurs with V_{CC} set to 3 V.

To activate the card at V_{CC} = 5 V, pin CMDVCCN must stay HIGH for t0 > 30 ms before going LOW (logic 0).

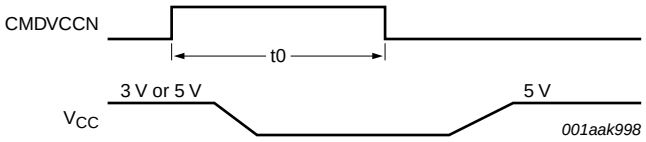

Fig 10. Card activation, V_{CC} = 5 V, t0 > 30 ms

To activate the card at V_{CC} = 3 V, pin CMDVCCN must stay HIGH for t0 < 15 ms before going LOW (logic 0).

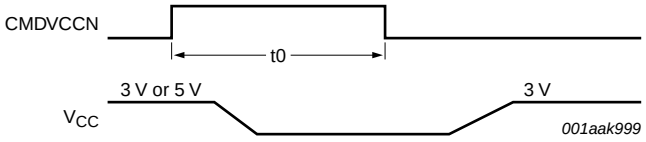

Fig 11. Card activation, V_{CC} = 3 V, t0 < 15 ms

If pin CMDVCCN is HIGH for more than 15 ms (t0 > 15 ms) but less than 30 ms, pin CMDVCCN must be set LOW for t1 (200 μs < t1 < 700 μs), and then HIGH for t2 (200 μs < t2 < 15 ms) before going LOW.

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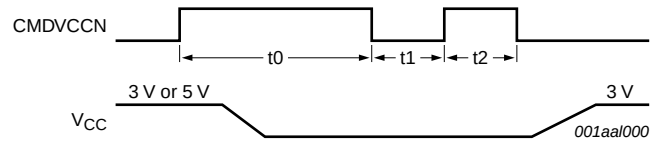

Fig 12. Card activation, V_{CC} = 3 V, t0 > 15 ms

If pin CMDVCCN is HIGH for more than 30 ms (card inactive), and if the card needs to be activated at 3 V, the sequence shown in Figure 12 applies: pin CMDVCCN must be set LOW for t1 (200 μs < t1 < 700 μs), and then HIGH for t2 (200 μs < t2 < 15 ms) before going LOW.

9. Limiting values

Remark: All card contacts are protected against any short-circuit to any other card contact. Stress beyond the levels indicated in Table 5 can cause permanent damage to the device. This is a short-term stress rating only and under no circumstances implies functional operation under long-term stress conditions.

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DDP}	power supply voltage	pin V_{DDP}	−0.3	+6	V
V_{DD}	supply voltage	pin V_{DD}	−0.3	+4.6	V
$V_{DD(INTF)}$	interface supply voltage	pin $V_{DD(INTF)}$	−0.3	+4.6	V
V_I	input voltage	pins CMDVCCN, CLKDIV1, RSTIN, OFFN, XTAL1, XTAL2, I/OUC	−0.3	+4.6	V
		card contact pins PRESN, I/O, RST and CLK	−0.3	+6	V
T_{stg}	storage temperature		−55	+150	°C
P_{tot}	total power dissipation	T_{amb} = −25 °C to +85 °C	-	0.25	W
T_j	junction temperature		-	+125	°C
T_{amb}	ambient temperature		−25	+85	°C
V_{ESD}	electrostatic discharge voltage	Human Body Model (HBM) on card pins I/O, RST, V_{CC}, CLK, PRESN; within typical application	−6	+6	kV
		Human Body Model (HBM); all other pins	−2	+2	kV
		Machine Model (MM); all pins	−200	+200	V
		Field Charged Device Model (FCDM); all pins	−500	+500	V

10. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Package name	Parameter	Conditions	Typ	Unit
$R_{th(j-a)}$	SO16	thermal resistance from junction to ambient	in free air	94	K/W

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11. Characteristics

Table 7. Characteristics of IC supply voltage

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Supply						
V_{DDP}	power supply voltage	pin V_{DDP}	4.85	5	5.5	V
V_{DD}	supply voltage	pin V_{DD}	2.7	3.3	3.6	V
$V_{DD(INTF)}$	interface supply voltage	pin $V_{DD(INTF)}$	1.6	3.3	V_{DD} + 0.3	V
I_{DD}	supply current	Shutdown mode	-	-	35	µA
I_{DDP}	power supply current	Shutdown mode				
		f_{xtal} stopped	-	-	5	µA
		Active mode				
		f_{CLK} = ½ f_{xtal}; no load	-	-	1.5	mA
		f_{CLK} = ½ f_{xtal}; I_{CC} = 65 mA	-	-	70	mA
$I_{DD(INTF)}$	interface supply current	Shutdown mode	-	-	6	µA
V_{th}	threshold voltage	pin V_{DD}	2.30	2.40	2.50	V
		pin V_{DDP}	3.00	4.10	4.40	V
V_{hys}	hysteresis voltage	pin V_{DD}	50	100	150	mV
		pin V_{DDP}	100	200	350	mV
t_w	pulse width		5.1	8	10.2	ms
Card supply voltage: pin V_{CC}[1]						
C_{dec}	decoupling capacitance	connected to V_{CC} [2]	550	-	830	nF
V_o	output voltage	Shutdown mode				
		no load	−0.1	-	+0.1	V
		I_o = 1 mA	−0.1	-	+0.3	V
I_o	output current	Shutdown mode; pin V_{CC} connected to ground	-	-	−1	mA
V_{CC}	supply voltage	active mode				
		5 V card				
		I_{CC} < 65 mA DC	4.75	5.0	5.25	V
		current pulses of 40 nA/s at I_{CC} < 200 mA; t < 400 ns	4.65	5.0	5.25	V
		3 V card				
		I_{CC} < 65 mA DC	2.85	3.05	3.15	V
		current pulses of 40 nA/s at I_{CC} < 200 mA; t < 400 ns	2.76	-	3.20	V
$V_{ripple(p-p)}$	peak-to-peak ripple voltage	20 kHz to 200 MHz	-	-	350	mV
I_{CC}	supply current	V_{CC} = 0 V to 5 V or 3 V	-	-	65	mA
		V_{CC} shorted to ground	90	120	150	mA
SR	slew rate	5 V card	0.055	0.180	0.300	V/µs
		3 V card	0.040	0.180	0.300	V/µs

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Table 7. Characteristics of IC supply voltage *…continued*

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Crystal oscillator: pins XTAL1 and XTAL2						
C_{ext}	external capacitance	pins XTAL1 and XTAL2 (depending on the crystal or resonator specification)	-	-	15	pF
f_{xtal}	crystal frequency	card clock reference; crystal oscillator	2	-	26	MHz
f_{ext}	external frequency	external clock on pin XTAL1	0	-	26	MHz
V_{IL}	LOW-level input voltage	crystal oscillator	−0.3	-	$+0.3V_{DD}$	V
		external clock	−0.3	-	$+0.3V_{DD(INTF)}$	V
V_{IH}	HIGH-level input voltage	crystal oscillator	$0.7V_{DD}$	-	V_{DD} + 0.3	V
		external clock	$0.7V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.3	V
Data lines: pins I/O and I/OUC						
t_d	delay time	falling edge on pins I/O and I/OUC or vise versa	-	-	200	ns
$t_{w(pu)}$	pull-up pulse width		200	-	400	ns
f_{io}	input/output frequency	on data lines	-	-	1	MHz
C_i	input capacitance	on data lines	-	-	10	pF
Data lines to the card: pin I/O[3]						
V_o	output voltage	Shutdown mode				
		no load	0	-	0.1	V
		I_o = 1 mA	0	-	0.3	V
I_o	output current	Shutdown mode; pin I/O grounded	-	-	−1	mA
V_{OL}	LOW-level output voltage	I_{OL} = 1 mA	0	-	0.3	V
		$I_{OL} \geq$ 15 mA	V_{CC} − 0.4	-	V_{CC}	V
V_{OH}	HIGH-level output voltage	no DC load	$0.9V_{CC}$	-	V_{CC} + 0.1	V
		$I_{OH} <$ −40 µA	$0.75V_{CC}$	-	V_{CC} + 0.1	V
		$I_{OH} \geq$ −15 mA	0	-	0.4	V
V_{IL}	LOW-level input voltage		−0.3	-	+0.8	V
V_{IH}	HIGH-level input voltage	V_{CC} = +5 V	$0.6V_{CC}$	-	V_{CC} + 0.3	V
		V_{CC} = +3 V	$0.7V_{CC}$	-	V_{CC} + 0.3	V
V_{hys}	hysteresis voltage	pin I/O	-	50	-	mV
I_{IL}	LOW-level input current	pin I/O; V_{IL} = 0 V	-	-	600	µA
I_{IH}	HIGH-level input current	pin I/O; $V_{IH} = V_{CC}$	-	-	10	µA
$t_{r(i)}$	input rise time	V_{IL} maximum to V_{IH} minimum	-	-	1.2	µs
$t_{r(o)}$	output rise time	$C_L \leq$ 80 pF; 10 % to 90 %; 0 V to V_{CC}	-	-	0.1	µs
$t_{f(i)}$	input fall time	V_{IL} maximum to V_{IH} minimum	-	-	1.2	µs

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Table 7. Characteristics of IC supply voltage *…continued*

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{f(o)}$	output fall time	$C_L \leq 80$ pF; 10 % to 90 %; 0 V to V_{CC}	-	-	0.1	µs
R_{pu}	pull-up resistance	connected to V_{CC}	7	9	11	kΩ
I_{pu}	pull-up current	$V_{OH} = 0.9V_{CC}$; C = 80 pF	−8	−6	−4	mA
Data lines to the system: pin I/OUC[4]						
V_{OL}	LOW-level output voltage	I_{OL} = 1 mA	0	-	0.3	V
V_{OH}	HIGH-level output voltage	no DC load	$0.9V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.1	V
		$I_{OH} \leq 40$ µA; $V_{DD(INTF)} > 2$ V	$0.75V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.1	V
		$I_{OH} \leq 20$ µA; $V_{DD(INTF)} < 2$ V	$0.75V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.1	V
V_{IL}	LOW-level input voltage		−0.3	-	$+0.3V_{DD(INTF)}$	V
V_{IH}	HIGH-level input voltage		$0.7V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.3	V
V_{hys}	hysteresis voltage	pin I/OUC	-	$0.14V_{DD(INTF)}$	-	V
I_{IH}	HIGH-level input current	$V_{IH} = V_{DD(INTF)}$	-	-	10	µA
I_{IL}	LOW-level input current	V_{IL} = 0 V	-	-	600	µA
R_{pu}	pull-up resistance	connected to $V_{DD(INTF)}$	8	10	12	kΩ
$t_{r(i)}$	input rise time	V_{IL} maximum to V_{IH} minimum	-	-	1.2	µs
$t_{r(o)}$	output rise time	$C_L \leq 30$ pF; 10 % to 90 %; 0 V to $V_{DD(INTF)}$	-	-	0.1	µs
$t_{f(i)}$	input fall time	V_{IL} maximum to V_{IH} minimum	-	-	1.2	µs
$t_{f(o)}$	output fall time	$C_L \leq 30$ pF; 10 % to 90 %; 0 V to $V_{DD(INTF)}$	-	-	0.1	µs
I_{pu}	pull-up current	$V_{OH} = 0.9V_{DD}$; C = 30 pF	−1	-	-	mA
Internal oscillator						
$f_{osc(int)}$	internal oscillator frequency	Shutdown mode	100	150	200	kHz
		active state	2	2.7	3.2	MHz
Reset output to the card: pin RST						
V_o	output voltage	Shutdown mode				
		no load	0	-	0.1	V
		I_o = 1 mA	0	-	0.3	V
I_o	output current	Shutdown mode; pin RST grounded	-	-	−1	mA
t_d	delay time	between pins RSTIN and RST; RST enabled	-	-	2	µs
V_{OL}	LOW-level output voltage	$I_{OL} = 200$ µA; V_{CC} = +5 V	0	-	0.3	V
		$I_{OL} = 200$ µA; V_{CC} = +3 V	0	-	0.2	V
		current limit I_{OL} = 20 mA	$V_{CC} - 0.4$	-	V_{CC}	V

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Table 7. Characteristics of IC supply voltage *…continued*

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{OH}	HIGH-level output voltage	I_{OH} = −200 µA	$0.9V_{CC}$	-	V_{CC}	V
		current limit I_{OH} = −20 mA	0	-	0.4	V
t_r	rise time	C_L = 100 pF	-	-	0.1	µs
t_f	fall time	C_L = 100 pF	-	-	0.1	µs
Clock output to the card: pin CLK						
V_o	output voltage	Shutdown mode				
		no load	0	-	0.1	V
		I_o = 1 mA	0	-	0.3	V
I_o	output current	Shutdown mode; pin CLK grounded	-	-	−1	mA
V_{OL}	LOW-level output voltage	I_{OL} = 200 µA	0	-	0.3	V
		current limit I_{OL} = 70 mA	V_{CC} − 0.4	-	V_{CC}	V
V_{OH}	HIGH-level output voltage	I_{OH} = −200 µA	$0.9V_{CC}$	-	V_{CC}	V
		current limit I_{OH} = −70 mA	0	-	0.4	V
t_r	rise time	C_L = 30 pF [5]	-	-	16	ns
t_f	fall time	C_L = 30 pF [5]	-	-	16	ns
f_{CLK}	frequency on pin CLK	operational	0	-	20	MHz
δ	duty cycle	C_L = 30 pF [5]	45	-	55	%
SR	slew rate	rise and fall; C_L = 30 pF				
		V_{CC} = +5 V	0.2	-	-	V/ns
		V_{CC} = +3 V	0.12	-	-	V/ns
Control inputs: pins CLKDIV1 and RSTIN[6]						
V_{IL}	LOW-level input voltage		−0.3	-	$0.3V_{DD(INTF)}$	V
V_{IH}	HIGH-level input voltage		$0.7\ V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.3	V
V_{hys}	hysteresis voltage	control input	-	$0.14\ V_{DD(INTF)}$	-	V
I_{IL}	LOW-level input current	V_{IL} = 0 V	-	-	1	µA
I_{IH}	HIGH-level input current	$V_{IH} = V_{DD(INTF)}$	-	-	1	µA
Control input: pin CMDVCCN[6]						
V_{IL}	LOW-level input voltage		−0.3	-	$0.3V_{DD(INTF)}$	V
V_{IH}	HIGH-level input voltage		$0.7V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.3	V
V_{hys}	hysteresis voltage	control input	-	$0.14V_{DD(INTF)}$	-	V
I_{IL}	LOW-level input current	V_{IL} = 0 V	-	-	1	µA
I_{IH}	HIGH-level input current	$V_{IH} = V_{DD(INTF)}$	-	-	1	µA
$f_{CMDVCCN}$	frequency on pin CMDVCCN		-	-	100	Hz

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Table 7. Characteristics of IC supply voltage *…continued*

V_{DDP} = 5 V; V_{DD} = 3.3 V; $V_{DD(INTF)}$ = 3.3 V; f_{xtal} = 10 MHz; GND = 0 V; T_{amb} = 25 °C; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_w	pulse width	5 V card; Figure 10	30	-	-	ms
		3 V card; Figure 11, Figure 12	-	-	15	ms
Card detection input[6][7]						
V_{IL}	LOW-level input voltage		–0.3	-	$0.3V_{DD(INTF)}$	V
V_{IH}	HIGH-level input voltage		$0.7V_{DD(INTF)}$	-	$V_{DD(INTF)}$ + 0.3	V
V_{hys}	hysteresis voltage	pin PRESN	-	$0.14V_{DD(INTF)}$	-	V
I_{IL}	LOW-level input current	0 V < V_{IL} < $V_{DD(INTF)}$	-	-	5	µA
I_{IH}	HIGH-level input current	0 V < V_{IH} < $V_{DD(INTF)}$	-	-	5	µA
OFFN output[8]						
V_{OL}	LOW-level output voltage	I_{OL} = 2 mA	0	-	0.3	V
V_{OH}	HIGH-level output voltage	I_{OH} = –15 µA	$0.75V_{DD(INTF)}$	-	-	V
R_{pu}	pull-up resistance	connected to $V_{DD(INTF)}$	16	20	24	kΩ

[1] To meet these specifications, V_{CC} should be decoupled to pin GND using two ceramic multilayer capacitors of low ESR with values of either 100 nF or one 220 nF and one 470 nF.

[2] Using decoupling capacitors of one 220 nF ± 20 % and one 470 nF ± 20 %.

[3] Using the integrated 9 kΩ pull-up resistor connected to V_{CC}.

[4] Using the integrated 10 kΩ pull-up resistor connected to $V_{DD(INTF)}$.

[5] The transition time and the duty factor definitions are shown in Figure 13 on page 20; δ = t1 / (t1 + t2).

[6] Pins PRESN and CMDVCCN are active LOW; pin RSTIN is active HIGH; see Table 4 for states of pin CLKDIV1.

[7] Pin PRESN has an integrated current source of 1.25 µA to $V_{DD(INTF)}$.

[8] Pin OFFN is an NMOS drain, using an internal 20 kΩ pull-up resistor connected to $V_{DD(INTF)}$.

Table 8. Protection characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_{Olim}	output current limit	pin I/O	-15	-	+15	mA
		pin V_{CC}	135	175	225	mA
		pin CLK	–70	-	+70	mA
		pin RST	–20	-	+20	mA
I_{sd}	shutdown current	pin V_{CC}	90	120	150	mA
T_{sd}	shutdown temperature	at die	-	150	-	°C

Table 9. Timing characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_{act}	activation time	see Figure 9 on page 13	2090	-	4160	µs
t_{deact}	deactivation time	see Figure 7 on page 11	35	90	250	µs

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Table 9. Timing characteristics *...continued*

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
t_d	delay time	CLK sent to card using an external clock				
		$t_{d(start)}$ = t3; see Figure 6 on page 10	2090	-	4112	µs
		$t_{d(end)}$ = t5; see Figure 6 on page 10	2120	-	4160	µs
t_{deb}	debounce time	pin PRESN	3.2	4.5	6.4	ms

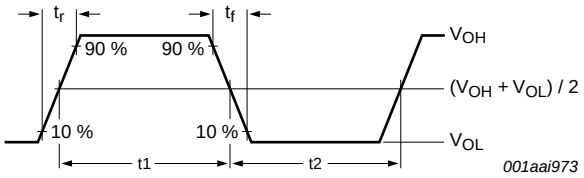

Fig 13. Definition of output and input transition times

12. Application information

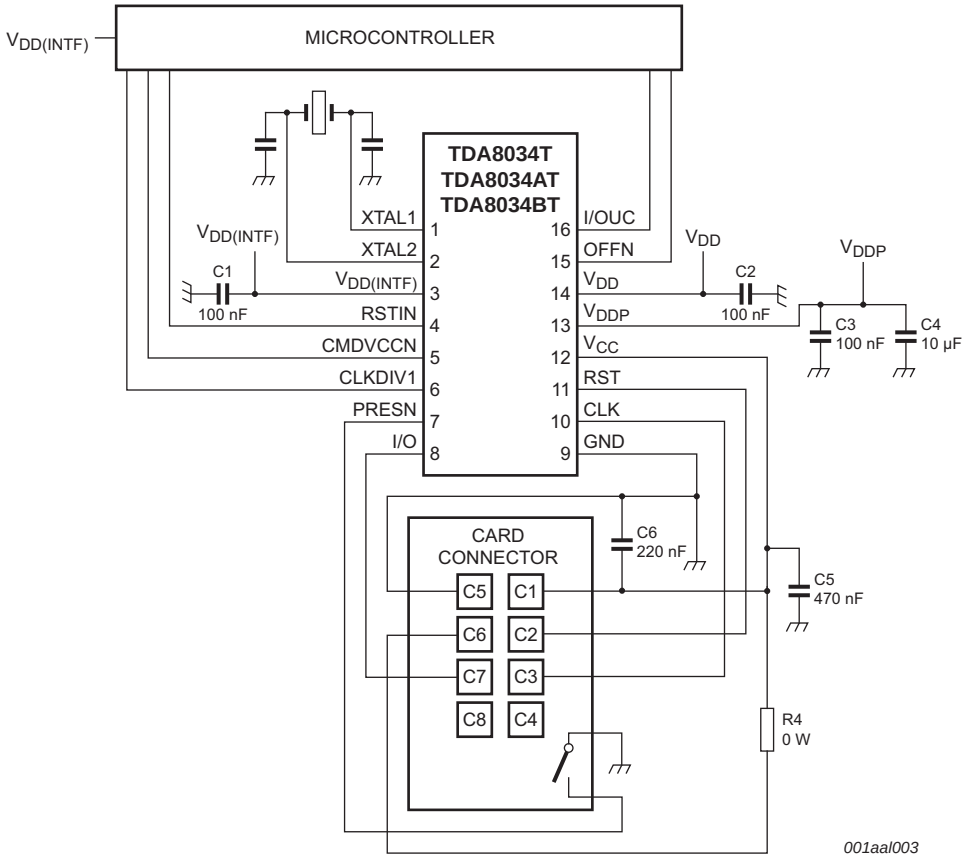

Fig 14. Application diagram

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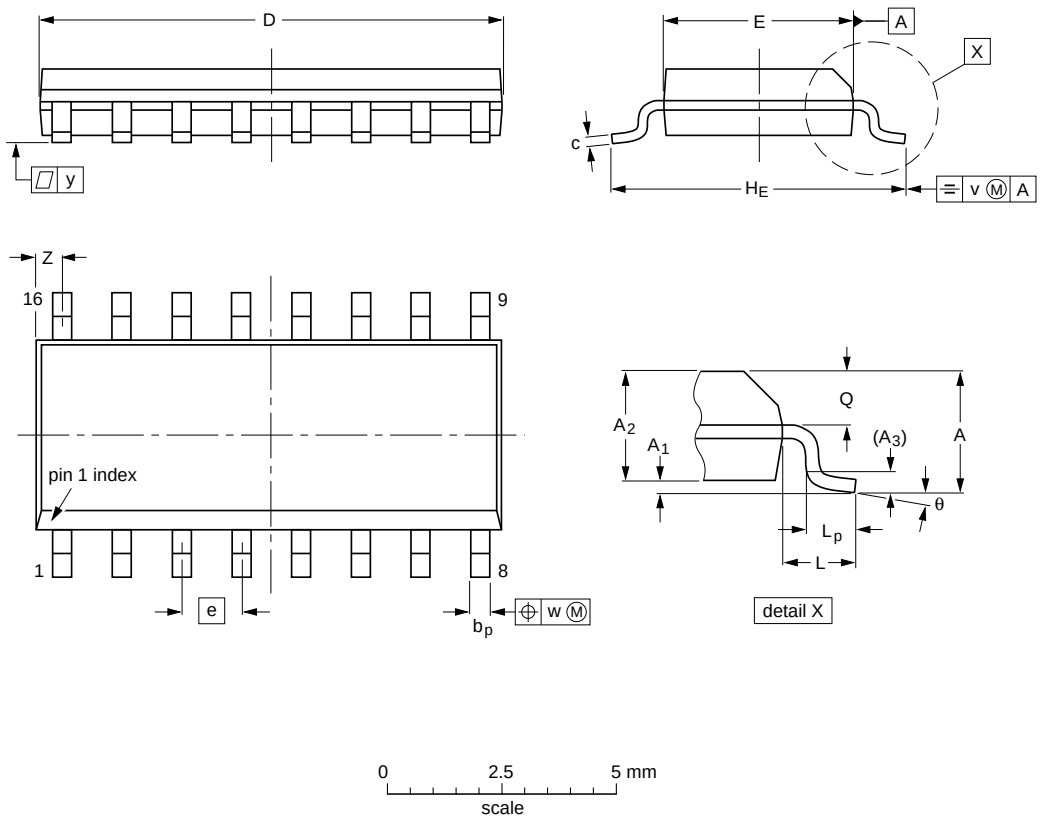
13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm **SOT109-1**



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A_1	A_2	A_3	b_p	c	$D^{(1)}$	$E^{(1)}$	e	H_E	L	L_p	Q	v	w	y	$Z^{(1)}$	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8^o 0^o
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.39 0.38	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	

Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT109-1	076E07	MS-012				~~99-12-27~~ 03-02-19

Fig 15. Package outline SOT109-1 (SO16)

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14. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365 "Surface mount reflow soldering description"*.

14.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

14.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

14.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

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14.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see Figure 16) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 10 and 11

Table 10. SnPb eutectic process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C)	
	Volume (mm^3)	
	< 350	≥ 350
< 2.5	235	220
≥ 2.5	220	220

Table 11. Lead-free process (from J-STD-020C)

Package thickness (mm)	Package reflow temperature (°C)		
	Volume (mm^3)		
	< 350	350 to 2000	> 2000
< 1.6	260	260	260
1.6 to 2.5	260	250	245
> 2.5	250	245	245

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 16.

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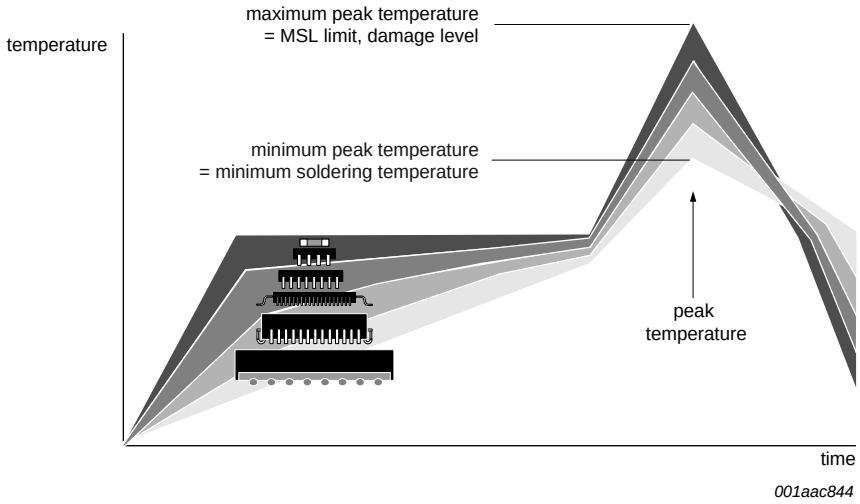

MSL: Moisture Sensitivity Level

Fig 16. Temperature profiles for large and small components

For further information on temperature profiles, refer to Application Note *AN10365 "Surface mount reflow soldering description"*.

15. Abbreviations

Table 12. Abbreviations

Acronym	Description
EMV	Europay MasterCard VISA
ESD	ElectroStatic Discharge
ESR	Equivalent Series Resistor
FCDM	Field Charged Device Model
HBM	Human Body Model
LDO	Low Drop-Out
MM	Machine Model
NMOS	Negative-channel Metal-Oxide Semiconductor
POR	Power-On Reset

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16. Revision history

Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
TDA8034T_TDA8034AT v.3.1	20121213	Product data sheet	-	TDA8034T_TDA8034AT v.3.0
Modifications:	• Section 8.1 “Power supplies”: updated			
TDA8034T_TDA8034AT v.3.0	20110117	Product data sheet	-	TDA8034T_TDA8034AT v.2.0
Modifications:	• Table 2 “Ordering information”: type numbers updated into TDA8034T/C1 and TDA8034AT/C1 • Table 3 “Pin description”: Table note [2] corrected			
TDA8034T_TDA8034AT v.2.0	20101112	Product data sheet	-	TDA8034T_TDA8034AT_1
Modifications:	• Table 3 “Pin description”: Table note [5] V_{DD} changed into $V_{DD(INTF)}$ Table note [6] added IOUC, AUX1UC, AUX2UC referenced to new note [6]			
TDA8034T_TDA8034AT_1	20100205	Product data sheet	-	-

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17. Legal information

17.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

17.2 Definitions

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